

# SSG4835P-VB Datasheet P-Channel 30-V (D-S) MOSFET

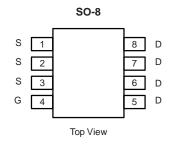
| PRODUCT SUMMARY     |                                    |                                 |                       |  |  |  |
|---------------------|------------------------------------|---------------------------------|-----------------------|--|--|--|
| V <sub>DS</sub> (V) | R <sub>DS(on)</sub> (Ω)            | I <sub>D</sub> (A) <sup>d</sup> | Q <sub>g</sub> (Typ.) |  |  |  |
| - 30                | 0.018 at V <sub>GS</sub> = - 10 V  | - 9.0                           | 13 nC                 |  |  |  |
| - 30                | 0.024 at V <sub>GS</sub> = - 4.5 V | - 7.8                           | 13110                 |  |  |  |

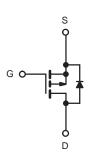
#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- Trench Power MOSFET •
- 100 % R<sub>g</sub> Tested ٠

#### **APPLICATIONS**

- Load Switch
- · Battery Switch





P-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS                           | A = 25 °C, unless othe            | erwise noted   |                       |    |  |
|--|-----------------------------------|----------------|-----------------------|----|--|
| Parameter  | Symbol                            | Limit          | Unit                  |    |  |
| Drain-Source Voltage                               | V <sub>DS</sub>                   | - 30           | V                     |    |  |
| Gate-Source Voltage                                | V <sub>GS</sub>                   | ± 20           | v                     |    |  |
|  | T <sub>C</sub> = 25 °C            |                | - 9.0                 |    |  |
| Continuous Drain Current (T <sub>1</sub> = 150 °C) | T <sub>C</sub> = 70 °C            |                | - 7.2                 |    |  |
| Continuous Drain Current $(1) = 150$ C)            | T <sub>A</sub> = 25 °C            |                | - 7.0 <sup>a, b</sup> |    |  |
|  | T <sub>A</sub> = 70 °C            |                | - 5.6 <sup>a, b</sup> | A  |  |
| Pulsed Drain Current                               | I <sub>DM</sub>                   | - 30           |                       |    |  |
| Continuous Courses Drain Diada Coursest            | T <sub>C</sub> = 25 °C            |                | - 3.5                 |    |  |
| Continuous Source-Drain Diode Current              | T <sub>A</sub> = 25 °C            | Is –           | - 2.1 <sup>a, b</sup> |    |  |
|  | T <sub>C</sub> = 25 °C            |                | 4.2                   |    |  |
| Manian and Disain stick                            | T <sub>C</sub> = 70 °C            |                | 2.7                   | w  |  |
| Maximum Power Dissipation                          | T <sub>A</sub> = 25 °C            | P <sub>D</sub> | 2.5 <sup>a, b</sup>   | VV |  |
|  | T <sub>A</sub> = 70 °C            | 1              | 1.6 <sup>a, b</sup>   |    |  |
| Operating Junction and Storage Temperature Rang    | T <sub>J</sub> , T <sub>stg</sub> | - 55 to 150    | °C                    |    |  |

| THERMAL RESISTANCE RATINGS                  |              |                   |         |         |      |  |
|---|--------------|-------------------|---------|---------|------|--|
| Parameter                                   |              | Symbol            | Typical | Maximum | Unit |  |
| Maximum Junction-to-Ambient <sup>a, c</sup> | t ≤ 10 s     | R <sub>thJA</sub> | 40      | 50      | °C/W |  |
| Maximum Junction-to-Foot                    | Steady State | R <sub>thJF</sub> | 24      | 30      | 0/00 |  |

Notes:

a. Surface mounted on 1" x 1" FR4 board.

b. t = 10 s.

c. Maximum under Steady State conditions is 95 °C/W.

d. Based on T<sub>C</sub> = 25 °C.





Available



| SPECIFICATIONS T <sub>J</sub> = 25 °C<br>Parameter | Symbol                               | Test Conditions  | Min.  | Typ.   | Max.  | Unit  |  |
|--|--------------------------------------|--|-------|--------|-------|-------|--|
| Static   |                                      |  |       |        |       |       |  |
| Drain-Source Breakdown Voltage                     | V <sub>DS</sub>                      | V <sub>GS</sub> = 0 V, I <sub>D</sub> = - 250 μA   | - 30  |        |       | V     |  |
| V <sub>DS</sub> Temperature Coefficient            | ΔV <sub>DS</sub> /T <sub>J</sub>     | $V_{DS}/T_J$ $l_{D} = -250 \mu A$  |       | - 31   |       |       |  |
| V <sub>GS(th)</sub> Temperature Coefficient        | ΔV <sub>GS(th)</sub> /T <sub>J</sub> |  |       | 4.5    |       | mV/°C |  |
| Gate-Source Threshold Voltage                      | V <sub>GS(th)</sub>                  | V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = - 250 μA  | - 1.0 |        | - 2.5 | V     |  |
| Gate-Source Leakage                                | I <sub>GSS</sub>                     | $V_{DS} = 0 V, V_{GS} = \pm 20 V$  |       |        | ± 100 | nA    |  |
| -  |                                      | $\frac{V_{DS} = -30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}}{V_{DS} = -30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 \text{ °C}}$ |       |        | - 1   | - μΑ  |  |
| Zero Gate Voltage Drain Current                    | IDSS                                 |  |       |        | - 5   |       |  |
| On-State Drain Current <sup>a</sup>                | I <sub>D(on)</sub>                   | $V_{DS} \le -5 V$ , $V_{GS} = -10 V$   | - 20  |        |       | Α     |  |
|  | _                                    | V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 7.0 A   |       | 0.018  |       | Ω     |  |
| Drain-Source On-State Resistance <sup>a</sup>      | R <sub>DS(on)</sub>                  | V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 5.6 A  |       | 0.024  |       |       |  |
| Forward Transconductance <sup>a</sup>              | 9 <sub>fs</sub>                      | V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 7.0 A   |       | 18     |       | S     |  |
| Dynamic <sup>b</sup>                               |                                      |  |       |        |       |       |  |
| Input Capacitance                                  | C <sub>iss</sub>                     |  |       | 1455   |       |       |  |
| Output Capacitance                                 | C <sub>oss</sub>                     | V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = 0 V, f = 1 MHz   |       | 180    |       | pF    |  |
| Reverse Transfer Capacitance                       | C <sub>rss</sub>                     |  |       | 145    |       |       |  |
| Total Gate Charge                                  | Q <sub>q</sub>                       | $V_{DS}$ = - 15 V, $V_{GS}$ = - 10 V, $I_{D}$ = - 7.0 A  |       | 25     | 38    |       |  |
|  | Ŭ                                    |  | 13    | 20     | nC    |       |  |
| Gate-Source Charge                                 | Q <sub>gs</sub>                      | $V_{DS}$ = - 15 V, $V_{GS}$ = - 4.5 V, $I_{D}$ = - 7.0 A   |       | 3.5    |       |       |  |
| Gate-Drain Charge                                  | Q <sub>gd</sub>                      |  |       | 5.5    |       |       |  |
| Gate Resistance                                    | R <sub>g</sub>                       | f = 1 MHz  | 0.4   | 2.0    | 4.0   | Ω     |  |
| Turn-On Delay Time                                 | t <sub>d(on)</sub>                   |  |       | 10     | 20    |       |  |
| Rise Time  | t <sub>r</sub>                       | $V_{DD}$ = - 15 V, $R_L$ = 2.7 $\Omega$  |       | 13     | 20    |       |  |
| Turn-Off DelayTime                                 | t <sub>d(off)</sub>                  | $I_{D}\cong$ - 5.6 A, $V_{GEN}$ = - 10 V, $R_{g}$ = 1 $\Omega$   |       | 23     | 35    |       |  |
| Fall Time  | t <sub>f</sub>                       |  |       | 9      | 18    | ns    |  |
| Turn-On Delay Time                                 | t <sub>d(on)</sub>                   |  |       | 38     | 57    | 115   |  |
| Rise Time  | t <sub>r</sub>                       | $V_{DD}$ = - 15 V, $R_L$ = 2.7 $\Omega$  |       | 89     | 134   |       |  |
| Turn-Off DelayTime                                 | t <sub>d(off)</sub>                  | $I_D\cong$ - 5.6 A, $V_{GEN}$ = - 4.5 V, $R_g$ = 1 $\Omega$  |       | 22     | 33    |       |  |
| Fall Time  | t <sub>f</sub>                       |  |       | 11     | 17    |       |  |
| Drain-Source Body Diode Characteris                | stics                                |  |       |        |       |       |  |
| Continous Source-Drain Diode Current               | ۱ <sub>S</sub>                       | T <sub>C</sub> = 25 °C   |       |        | - 6.5 | A     |  |
| Pulse Diode Forward Current                        | I <sub>SM</sub>                      |  |       |        | - 30  | А     |  |
| Body Diode Voltage                                 | $V_{SD}$                             | I <sub>S</sub> = - 5.6 A, V <sub>GS</sub> = 0 V  |       | - 0.71 | - 1.2 | V     |  |
| Body Diode Reverse Recovery Time                   | t <sub>rr</sub>                      |  |       | 22     | 33    | ns    |  |
| Body Diode Reverse Recovery Charge Q <sub>rr</sub> |                                      | I = 560 dl/dt = 1000//ma T = 0500  |       | 17     | 26    | nC    |  |
| Reverse Recovery Fall Time                         | t <sub>a</sub>                       | $I_F = -5.6 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$   |       | 13     |       | 20    |  |
| Reverse Recovery Rise Time                         | t <sub>b</sub>                       |  |       | 9      |       | ns    |  |

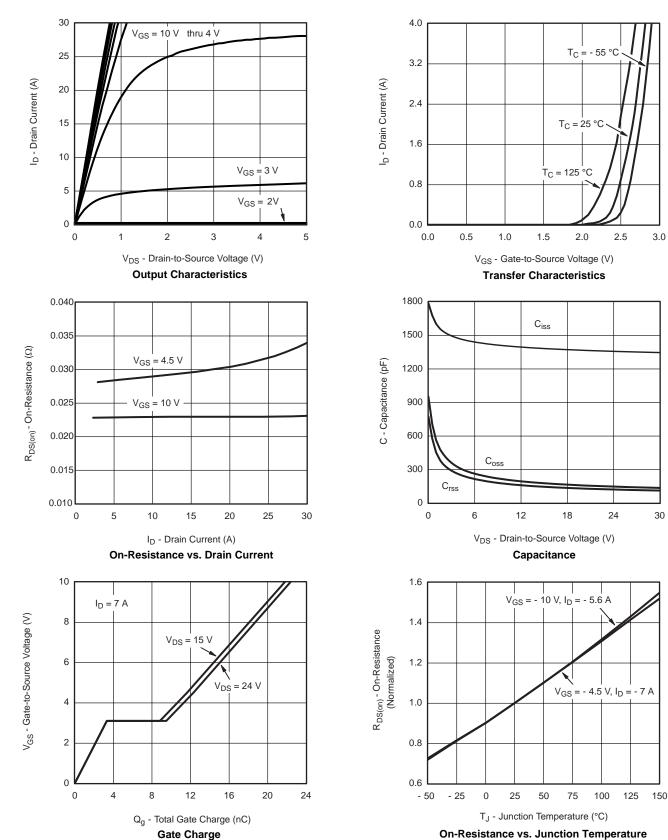
Notes:

a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %.

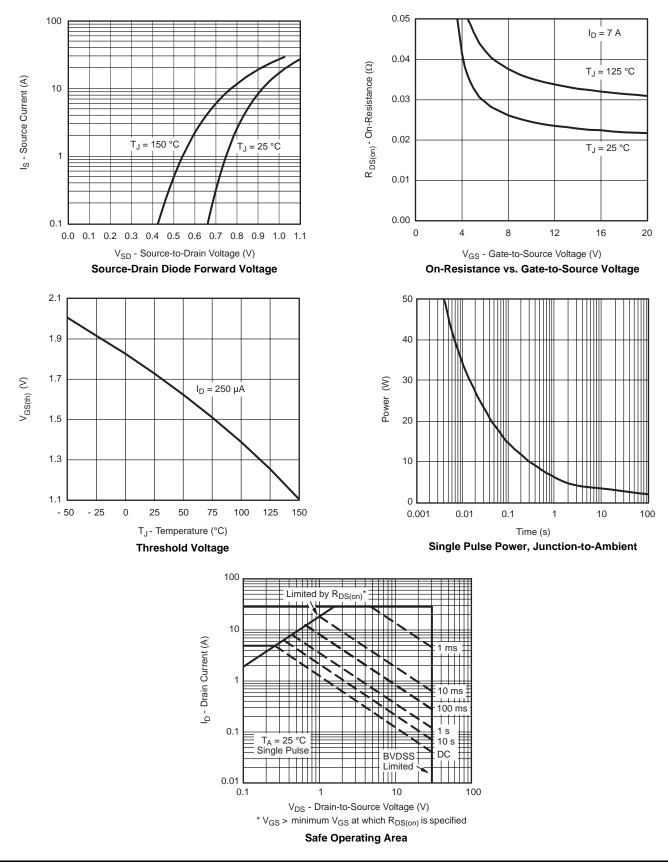
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

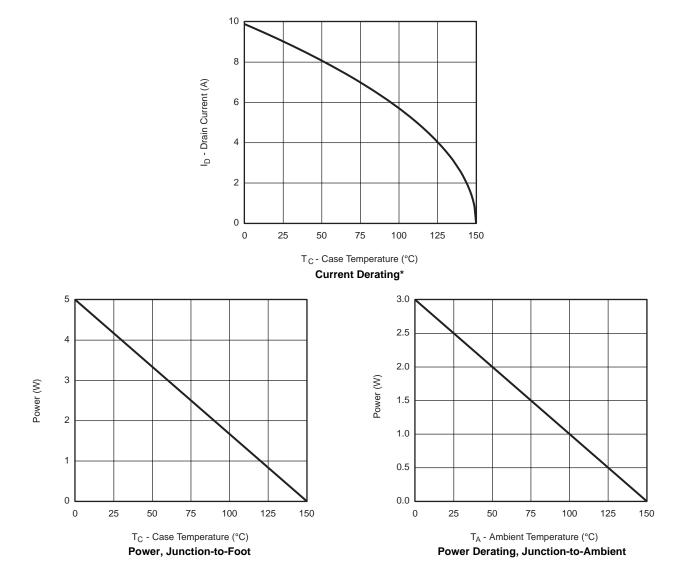






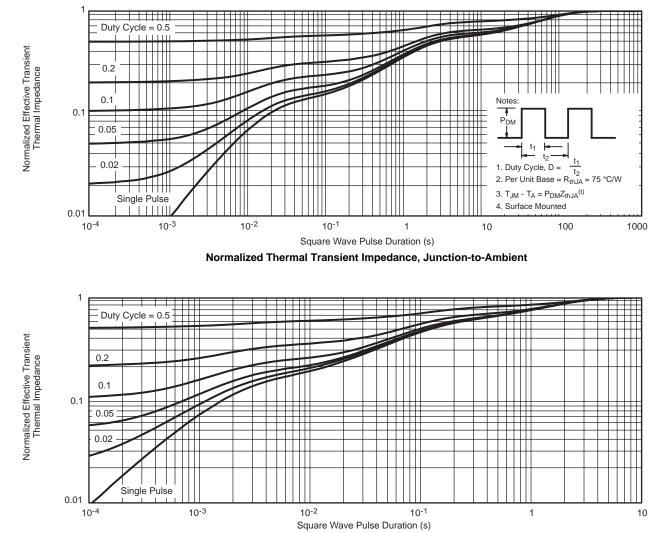






\* The power dissipation  $P_D$  is based on  $T_{J(max)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Foot



# SOIC (NARROW): 8-LEAD

JEDEC Part Number: MS-012

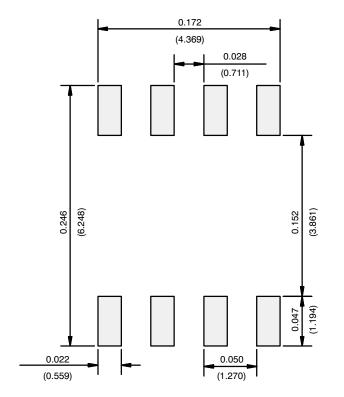




|   | MILLIMETERS |      | INC    | INCHES    |  |  |
|---|-------------|------|--------|-----------|--|--|
| DIM   | Min         | Мах  | Min    | Max       |  |  |
| A   | 1.35        | 1.75 | 0.053  | 0.069     |  |  |
| A <sub>1</sub>                              | 0.10        | 0.20 | 0.004  | 0.008     |  |  |
| В   | 0.35        | 0.51 | 0.014  | 0.020     |  |  |
| С   | 0.19        | 0.25 | 0.0075 | 0.010     |  |  |
| D   | 4.80        | 5.00 | 0.189  | 0.196     |  |  |
| E   | 3.80        | 4.00 | 0.150  | 0.157     |  |  |
| е   | 1.27 BSC    |      | 0.050  | 0.050 BSC |  |  |
| Н   | 5.80        | 6.20 | 0.228  | 0.244     |  |  |
| h   | 0.25        | 0.50 | 0.010  | 0.020     |  |  |
| L   | 0.50        | 0.93 | 0.020  | 0.037     |  |  |
| q   | 0°          | 8°   | 0°     | 8°        |  |  |
| S   | 0.44        | 0.64 | 0.018  | 0.026     |  |  |
| ECN: C-06527-Rev. I, 11-Sep-06<br>DWG: 5498 |             |      |        |           |  |  |



**RECOMMENDED MINIMUM PADS FOR SO-8** 



Recommended Minimum Pads Dimensions in Inches/(mm)



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